3D Machine Vision Preparation for Exam



Which content is relevant for examination

- 1. relevant/non-relevant slides
- 2. relevant algorithms
- 3. relevant formulas
- 4. relevant terms
- 5. relevant data formats
- 6. relevant procedures/errors

Exam





- slide contents are relevant to the exam.
- contents of the exercises are relevant to the exam
- Blackboard notes are relevant to the exam
- type of examination: written
- Date of examination: Tuesday 07/18/2023, 11:00 am, Campus 1, Room 5.2.04
- Exam Duration: 90 minutes
- Aids: 2 DIN A4 pages handwritten on both sides

Exam





Content that is relevant for the exam

1. Introduction: S.12-S.16

2. 3D Cameras: S.2-S.25, S.29-S.30

3. 3D Data Representation: S.2-S.23

4. 3D Data Processing: S.2-S.5, S.9-S.31, S.33-42

5. Correspondence Search: S.2-S.31, S.35-S.83

6. Epipolar Geometry: S.2-S.43

Exam



Content that is not relevant for the exam

1. Introduction: S.17-S.41

2. 3D Cameras: S.26-S.28, S.31-S.36

3. 3D Data Representation: S.24

4. 3D Datenverarbeitung: S.6-S.8, S.32, S.43-S.59

Correspondence Search: S.32-S.34

6. Epipolar Geometry: none!

Exam - Algorithms,

... that you should be able to explain



- 1. Quadtree-Decomposition
- 2. Kd.tree-Decomposition (2D)
- 3. Sequence of nearest neighbor search in Kd-tree
- 4. Regression with singular value decomposition
- 5. RANSAC algorithm
- 6. Construction of the Gaussian and Laplace Pyramid
- Eight-point algorithm
- 8. Rectification

Exam - Formulas,

... that you should be able to read



- 1. mean, variance, covariance matrix, correlation coefficient
- 2. 1D Gaussian distribution, Multivariate Gaussian distribution
- 3. All different auto/cross correlation functions
- 4. Local Template Matching Measures (SSD, SAD)

Exam - Data Formats,

... that you should be able to read



1. PLY-Data Format

Exam - Terms,



... that you should be able to explain

- 1. depth value, depth range, depth resolution, dynamic range, distance, disparity
- 2. topology, triangular fan, voxel, RGB-D image, octree
- 3. data matrix, data covariance matrix, Mahalanobis distance, precision matrix
- 4. regression, vertical error/offset, orthogonal error/offset, pseudoinverse
- 5. eigenvalues/vectors, singular values/vectors, singular value decomposition, principal component analysis
- 6. Hessian normal form, structure tensor, null space
- 7. invariance, discriminativity, scale space, descriptor
- 8. optical flow, correspondence problem, aperture problem
- 9. baseline, epipole, epipolar line, epipolar plane, essential matrix
- 10. epipolar constraint, geometric error, reprojection error

Exam - Procedures/Errors,

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... that you should be able to explain

- 1. Systematic and Random Errors in Depth Measurement
- Different time-of-flight measurement techniques (pulsed & modulated light)
- 3. Passive/Active Stereoscopic Vision
- 4. Design of a HoG descriptor
- 5. Coarse-to-fine strategy (multiscale approach)
- Different triangulation methods